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Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Obsolete
Core Processor	ST7
Core Size	8-Bit
Speed	8MHz
Connectivity	SCI, SPI
Peripherals	LVD, POR, PWM, WDT
Number of I/O	32
Program Memory Size	8KB (8K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	384 x 8
Voltage - Supply (Vcc/Vdd)	3.8V ~ 5.5V
Data Converters	A/D 12x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	44-LQFP
Supplier Device Package	-
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/st72f324bj2t6

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4.3.1 Readout protection

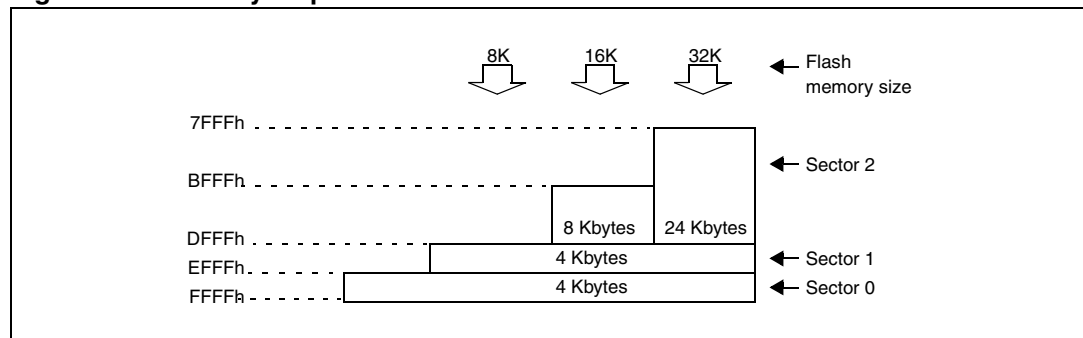
Readout protection, when selected, provides a protection against program memory content extraction and against write access to Flash memory. Even if no protection can be considered as totally unbreakable, the feature provides a very high level of protection for a general purpose microcontroller.

In Flash devices, this protection is removed by reprogramming the option. In this case, the entire program memory is first automatically erased.

Readout protection selection depends on the device type:

- In Flash devices it is enabled and removed through the FMP_R bit in the option byte.
- In ROM devices it is enabled by mask option specified in the option list.

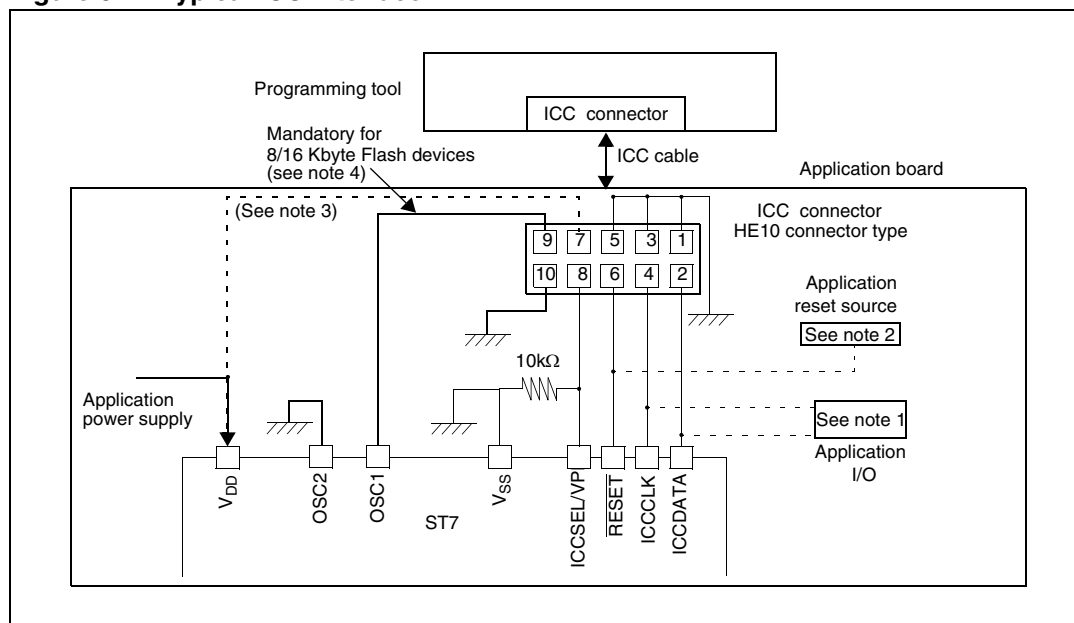
Figure 5. Memory map and sector address



4.4 ICC interface

ICC needs a minimum of 4 and up to 6 pins to be connected to the programming tool (see [Figure 6](#)). These pins are:

- $\overline{\text{RESET}}$: device reset
- V_{SS} : device power supply ground
- ICCCLK: ICC output serial clock pin
- ICCDATA: ICC input/output serial data pin
- ICCSEL/ V_{PP} : programming voltage
- OSC1 (or OSCIN): main clock input for external source (optional)
- V_{DD} : application board power supply (optional, see [Figure 6](#), Note 3).

Figure 6. Typical ICC interface

1. If the ICCCLK or ICCDATA pins are only used as outputs in the application, no signal isolation is necessary. As soon as the programming tool is plugged to the board, even if an ICC session is not in progress, the ICCCLK and ICCDATA pins are not available for the application. If they are used as inputs by the application, isolation such as a serial resistor has to be implemented in case another device forces the signal. Refer to the Programming Tool documentation for recommended resistor values.
2. During the ICC session, the programming tool must control the RESET pin. This can lead to conflicts between the programming tool and the application reset circuit if it drives more than 5mA at high level (PUSH-pull output or pull-up resistor <1K). A schottky diode can be used to isolate the application reset circuit in this case. When using a classical RC network with $R > 1K$ or a reset management IC with open drain output and pull-up resistor $> 1K$, no additional components are needed. In all cases the user must ensure that no external reset is generated by the application during the ICC session.
3. The use of Pin 7 of the ICC connector depends on the programming tool architecture. This pin must be connected when using most ST programming tools (it is used to monitor the application power supply). Please refer to the programming tool manual.
4. Pin 9 has to be connected to the OSC1 (OSCIN) pin of the ST7 when the clock is not available in the application or if the selected clock option is not programmed in the option byte. ST7 devices with multi-oscillator capability need to have OSC2 grounded in this case.

Caution: External clock ICC entry mode is mandatory in ST72F324B 8/16 Kbyte Flash devices. In this case pin 9 must be connected to the OSC1 (OSCIN) pin of the ST7 and OSC2 must be grounded. 32 Kbyte Flash devices may use external clock or application clock ICC entry mode.

4.5 ICP (in-circuit programming)

To perform ICP the microcontroller must be switched to ICC (in-circuit communication) mode by an external controller or programming tool.

Depending on the ICP code downloaded in RAM, Flash memory programming can be fully customized (number of bytes to program, program locations, or selection serial communication interface for downloading).

When using an STMicroelectronics or third-party programming tool that supports ICP and the specific microcontroller device, the user needs only to implement the ICP hardware interface on the application board (see [Figure 6](#)). For more details on the pin locations, refer to the device pinout description.

Figure 10-1: Interrupt priority management. The diagram shows the stack usage for various interrupts and the Main program. The vertical axis represents Hardware priority and Software priority level. The horizontal axis represents Used stack = 20 bytes. The diagram shows the stack usage for Main (11/10), IT2, IT1, IT4, IT3, TRAP, IT0, IT1, IT2, IT3, IT4, and Main (10).

7.5.1 CPU CC register interrupt bits

Reset value: 111x 1010(xAh)

7	6	5	4	3	2	1	0
1	1	I1	H	I0	N	Z	C
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W

Bit	Name	Function
5	I1	Software Interrupt Priority 1
3	I0	Software Interrupt Priority 0

Interrupt software priority	Level	I1	I0
Level 0 (main)	Low	1	0
Level 1	↓	0	1
Level 2		0	0
Level 3 (= interrupt disable) ⁽¹⁾		High	1

These two bits indicate the current interrupt software priority (see [Table 16](#)) and are set/cleared by hardware when entering in interrupt. The loaded value is given by the corresponding bits in the interrupt software priority registers (ISPRx).

Table 25. Interrupt mapping

No.	Source block	Description	Register label	Priority order	Exit from Halt/Active Halt	Address vector
	Reset	Reset	N/A		yes	FFFEh-FFFFh
	TRAP	Software interrupt			no	FFFCh-FFFDh
0	Not used					FFFAh-FFFBh
1	MCC/RTC	Main clock controller time base interrupt	MCCSR	<div>Higher priority</div> <div>↓</div> <div>Lower priority</div>	yes	FFF8h-FFF9h
2	ei0	External interrupt port A3..0	N/A		yes	FFF6h-FFF7h
3	ei1	External interrupt port F2..0			yes	FFF4h-FFF5h
4	ei2	External interrupt port B3..0			yes	FFF2h-FFF3h
5	ei3	External interrupt port B7..4			yes	FFF0h-FFF1h
6	Not used					FFEEh-FFEFh
7	SPI	SPI peripheral interrupts	SPICSR		yes	FFECCh-FFEDh
8	Timer A	Timer A peripheral interrupts	TASR		no	FFEAh-FFEBh
9	Timer B	Timer B peripheral interrupts	TBSR		no	FFE8h-FFE9h
10	SCI	SCI peripheral interrupts	SCISR		no	FFE6h-FFE7h
11	AVD	Auxiliary voltage detector interrupt	SICSR		no	FFE4h-FFE5h

Halt mode recommendations

- Make sure that an external event is available to wake up the microcontroller from Halt mode.
- When using an external interrupt to wake up the microcontroller, reinitialize the corresponding I/O as “Input Pull-up with Interrupt” before executing the HALT instruction. The main reason for this is that the I/O may be wrongly configured due to external interference or by an unforeseen logical condition.
- For the same reason, reinitialize the sensitivity level of each external interrupt as a precautionary measure.
- The opcode for the HALT instruction is 0x8E. To avoid an unexpected HALT instruction due to a program counter failure, it is advised to clear all occurrences of the data value 0x8E from memory. For example, avoid defining a constant in ROM with the value 0x8E.
- As the HALT instruction clears the interrupt mask in the CC register to allow interrupts, the user may choose to clear all pending interrupt bits before executing the HALT instruction. This avoids entering other peripheral interrupt routines after executing the external interrupt routine corresponding to the wake-up event (reset or external interrupt).

External interrupt function

When an I/O is configured as 'Input with Interrupt', an event on this I/O can generate an external interrupt request to the CPU.

Each pin can independently generate an interrupt request. The interrupt sensitivity is independently programmable using the sensitivity bits in the EICR register.

Each external interrupt vector is linked to a dedicated group of I/O port pins (see pinout description and interrupt section). If several input pins are selected simultaneously as interrupt sources, these are first detected according to the sensitivity bits in the EICR register and then logically ORed.

The external interrupts are hardware interrupts, which means that the request latch (not accessible directly by the application) is automatically cleared when the corresponding interrupt vector is fetched. To clear an unwanted pending interrupt by software, the sensitivity bits in the EICR register must be modified.

9.2.2 Output modes

The output configuration is selected by setting the corresponding DDR register bit. In this case, writing the DR register applies this digital value to the I/O pin through the latch. Then reading the DR register returns the previously stored value.

Two different output modes can be selected by software through the OR register: Output push-pull and open-drain.

Table 27. DR register value and output pin status

DR	Push-pull	Open-drain
0	V_{SS}	V_{SS}
1	V_{DD}	Floating

9.2.3 Alternate functions

When an on-chip peripheral is configured to use a pin, the alternate function is automatically selected. This alternate function takes priority over the standard I/O programming.

When the signal is coming from an on-chip peripheral, the I/O pin is automatically configured in output mode (push-pull or open drain according to the peripheral).

When the signal is going to an on-chip peripheral, the I/O pin must be configured in input mode. In this case, the pin state is also digitally readable by addressing the DR register.

Note: Input pull-up configuration can cause unexpected value at the input of the alternate peripheral input. When an on-chip peripheral use a pin as input and output, this pin has to be configured in input floating mode.

Figure 28. I/O port general block diagram

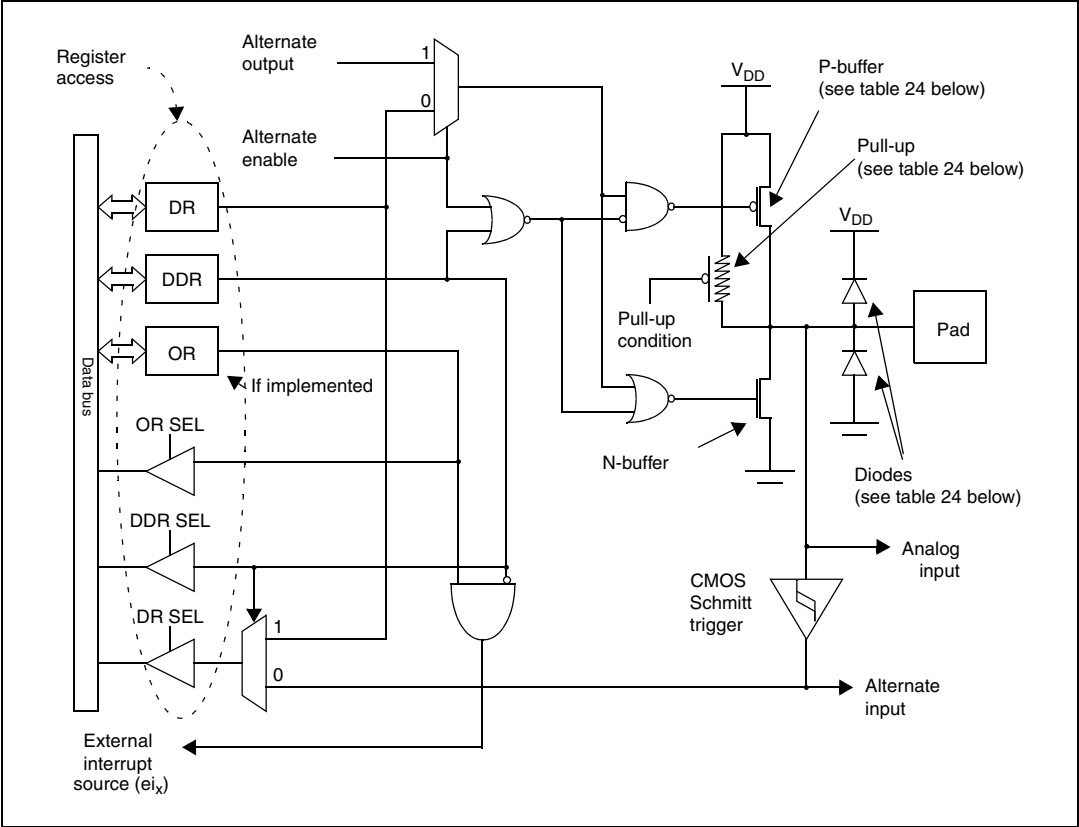


Table 28. I/O port mode options

Configuration mode		Pull-up	P-buffer	Diodes	
				to V _{DD} ⁽¹⁾	to V _{SS} ⁽²⁾
Input	Floating with/without Interrupt	Off ⁽³⁾	Off	On	On
	Pull-up with/without Interrupt	On ⁽⁴⁾			
Output	Push-pull	Off	On	On	On
	Open drain (logic level)		Off		
	True open drain	NI	NI	NI ⁽⁵⁾	

1. The diode to V_{DD} is not implemented in the true open drain pads.
2. A local protection between the pad and V_{SS} is implemented to protect the device against positive stress.
3. Off = implemented not activated.
4. On = implemented and activated.
5. NI = not implemented

Input Capture 1 Low Register (IC1LR)

This is an 8-bit register that contains the low part of the counter value (transferred by the input capture 1 event).

IC1LR							Reset value: undefined
7	6	5	4	3	2	1	0
MSB							LSB
RO	RO	RO	RO	RO	RO	RO	RO

Output Compare 1 High Register (OC1HR)

This is an 8-bit register that contains the high part of the value to be compared to the CHR register.

OC1HR							Reset value: 1000 0000 (80h)
7	6	5	4	3	2	1	0
MSB							LSB
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W

Output Compare 1 Low Register (OC1LR)

This is an 8-bit register that contains the low part of the value to be compared to the CLR register.

OC1LR							Reset value: 0000 0000 (00h)
7	6	5	4	3	2	1	0
MSB							LSB
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W

Output Compare 2 High Register (OC2HR)

This is an 8-bit register that contains the high part of the value to be compared to the CHR register.

OC2HR							Reset value: 1000 0000 (80h)
7	6	5	4	3	2	1	0
MSB							LSB
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W

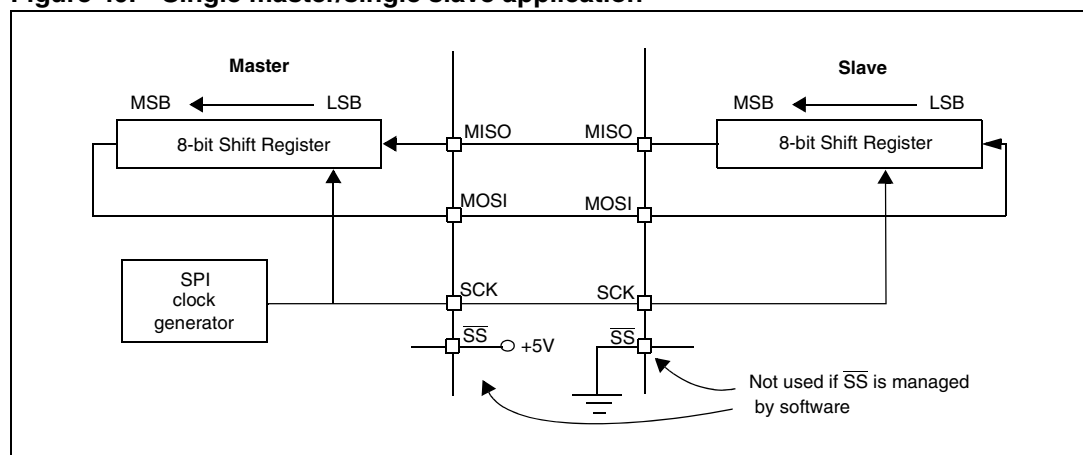
The MOSI pins are connected together and the MISO pins are connected together. In this way data is transferred serially between master and slave (most significant bit first).

The communication is always initiated by the master. When the master device transmits data to a slave device via MOSI pin, the slave device responds by sending data to the master device via the MISO pin. This implies full duplex communication with both data out and data in synchronized with the same clock signal (which is provided by the master device via the SCK pin).

To use a single data line, the MISO and MOSI pins must be connected at each node (in this case only simplex communication is possible).

Four possible data/clock timing relationships may be chosen (see [Figure 52](#)) but master and slave must be programmed with the same timing mode.

Figure 49. Single master/single slave application



Slave Select management

As an alternative to using the \overline{SS} pin to control the Slave Select signal, the application can choose to manage the Slave Select signal by software. This is configured by the SSM bit in the SPICSR register (see [Figure 51](#)).

In software management, the external \overline{SS} pin is free for other application uses and the internal \overline{SS} signal level is driven by writing to the SSI bit in the SPICSR register.

In Master mode:

- \overline{SS} internal must be held high continuously

Depending on the data/clock timing relationship, there are two cases in Slave mode (see [Figure 50](#)):

If CPHA = 1 (data latched on second clock edge):

- \overline{SS} internal must be held low during the entire transmission. This implies that in single slave applications the \overline{SS} pin either can be tied to V_{SS} , or made free for standard I/O by managing the \overline{SS} function by software (SSM = 1 and SSI = 0 in the in the SPICSR register)

If CPHA = 0 (data latched on first clock edge):

- \overline{SS} internal must be held low during byte transmission and pulled high between each byte to allow the slave to write to the shift register. If \overline{SS} is not pulled high, a Write

The SPIF bit can be cleared during a second transmission; however, it must be cleared before the second SPIF bit in order to prevent an Overrun condition (see [Overrun condition \(OVR\) on page 103](#)).

10.4.4 Clock phase and clock polarity

Four possible timing relationships may be chosen by software, using the CPOL and CPHA bits (see [Figure 52](#)).

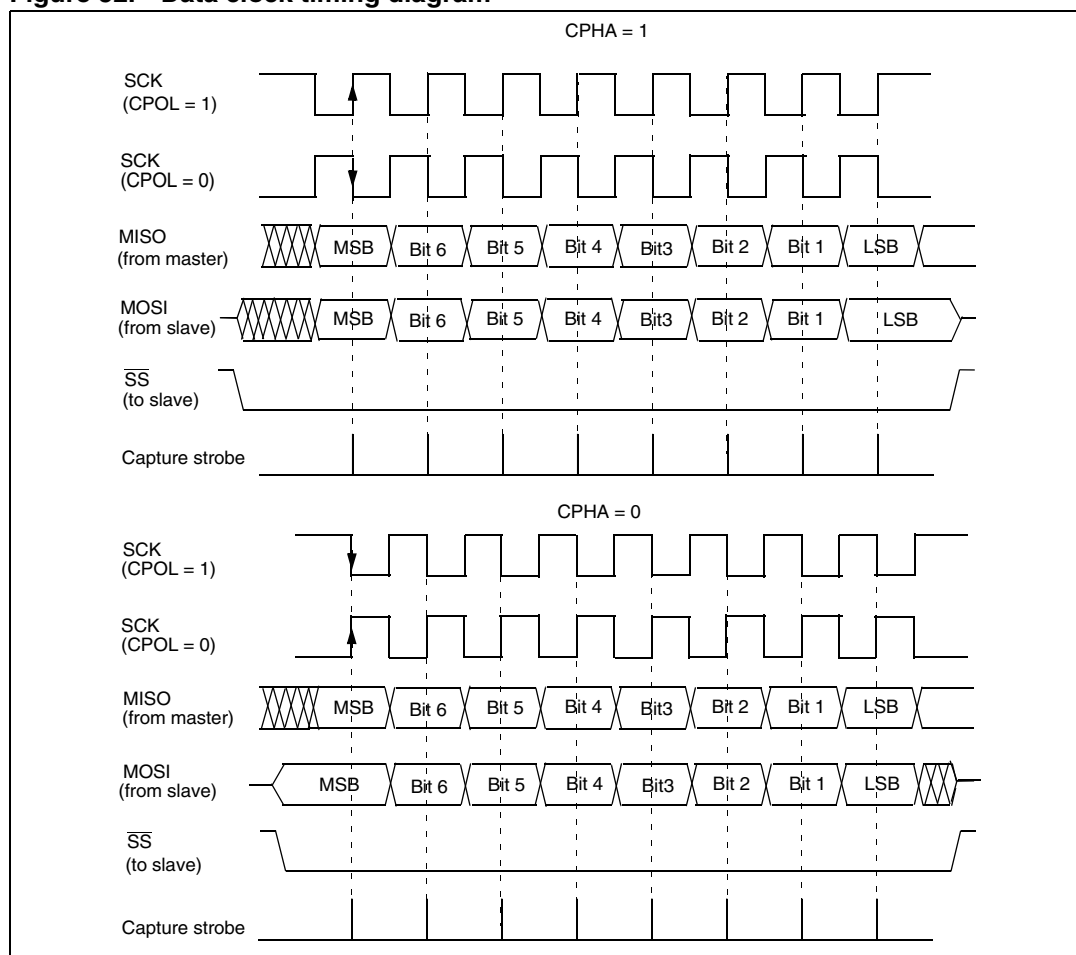
Note: *The idle state of SCK must correspond to the polarity selected in the SPICSR register (by pulling up SCK if CPOL = 1 or pulling down SCK if CPOL = 0).*

The combination of the CPOL clock polarity and CPHA (clock phase) bits selects the data capture clock edge

[Figure 52](#) shows an SPI transfer with the four combinations of the CPHA and CPOL bits. The diagram may be interpreted as a master or slave timing diagram where the SCK, MISO and MOSI pins are directly connected between the master and the slave device.

Note: *If CPOL is changed at the communication byte boundaries, the SPI must be disabled by resetting the SPE bit.*

Figure 52. Data clock timing diagram⁽¹⁾



1. This figure should not be used as a replacement for parametric information. Refer to the Electrical Characteristics chapter.

Table 63. SCICR1 register description (continued)

Bit	Name	Function
3	WAKE	Wake-Up method This bit determines the SCI Wake-Up method, it is set or cleared by software. 0: Idle line 1: Address mark
2	PCE	Parity Control Enable This bit selects the hardware parity control (generation and detection). When the parity control is enabled, the computed parity is inserted at the MSB position (9th bit if M = 1; 8th bit if M = 0) and parity is checked on the received data. This bit is set and cleared by software. Once it is set, PCE is active after the current byte (in reception and in transmission). 0: Parity control disabled 1: Parity control enabled
1	PS	Parity Selection This bit selects the odd or even parity when the parity generation/detection is enabled (PCE bit set). It is set and cleared by software. The parity will be selected after the current byte. 0: Even parity 1: Odd parity
0	PIE	Parity Interrupt Enable This bit enables the interrupt capability of the hardware parity control when a parity error is detected (PE bit set). It is set and cleared by software. 0: Parity error interrupt disabled 1: Parity error interrupt enabled

SCI Control Register 2 (SCICR2)

SCICR2

Reset value: 0000 0000 (00h)

7	6	5	4	3	2	1	0
TIE	TCIE	RIE	ILIE	TE	RE	RWU	SBK
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W

Table 64. SCICR2 register description

Bit	Name	Function
7	TIE	Transmitter Interrupt Enable This bit is set and cleared by software. 0: Interrupt is inhibited 1: An SCI interrupt is generated whenever TDRE = 1 in the SCISR register.
6	TCIE	Transmission Complete Interrupt Enable This bit is set and cleared by software. 0: Interrupt is inhibited 1: An SCI interrupt is generated whenever TC = 1 in the SCISR register.

Table 64. SCICR2 register description (continued)

Bit	Name	Function
5	RIE	Receiver interrupt Enable This bit is set and cleared by software. 0: Interrupt is inhibited 1: An SCI interrupt is generated whenever OR = 1 or RDRF = 1 in the SCISR register.
4	ILIE	Idle Line Interrupt Enable This bit is set and cleared by software. 0: Interrupt is inhibited 1: An SCI interrupt is generated whenever IDLE = 1 in the SCISR register.
3	TE	Transmitter Enable This bit enables the transmitter. It is set and cleared by software. 0: Transmitter is disabled 1: Transmitter is enabled <i>Notes:</i> - During transmission, a '0' pulse on the TE bit ('0' followed by '1') sends a preamble (idle line) after the current word. - When TE is set there is a 1 bit-time delay before the transmission starts. Caution: The TDO pin is free for general purpose I/O only when the TE and RE bits are both cleared (or if TE is never set).
2	RE	Receiver Enable This bit enables the receiver. It is set and cleared by software. 0: Receiver is disabled 1: Receiver is enabled and begins searching for a start bit <i>Note:</i> Before selecting Mute mode (setting the RWU bit), the SCI must first receive some data, otherwise it cannot function in Mute mode with Wake-Up by Idle line detection.
1	RWU	Receiver Wake-Up This bit determines if the SCI is in mute mode or not. It is set and cleared by software and can be cleared by hardware when a wake-up sequence is recognized. 0: Receiver in Active mode 1: Receiver in Mute mode
0	SBK	Send Break This bit set is used to send break characters. It is set and cleared by software. 0: No break character is transmitted. 1: Break characters are transmitted. <i>Note:</i> If the SBK bit is set to '1' and then to '0', the transmitter will send a Break word at the end of the current word.

Table 69. SCI register map and reset values

Address (Hex.)	Register label	7	6	5	4	3	2	1	0
0050h	SCISR Reset value	TDRE 1	TC 1	RDRF 0	IDLE 0	OR 0	NF 0	FE 0	PE 0
0051h	SCIDR Reset value	MSB x	x	x	x	x	x	x	LSB x
0052h	SCIBRR Reset value	SCP1 0	SCP0 0	SCT2 0	SCT1 0	SCT0 0	SCR2 0	SCR1 0	SCR0 0
0053h	SCICR1 Reset value	R8 x	T8 0	SCID 0	M 0	WAKE 0	PCE 0	PS 0	PIE 0
0054h	SCICR2 Reset value	TIE 0	TCIE 0	RIE 0	ILIE 0	TE 0	RE 0	RWU 0	SBK 0
0055h	SCIERPR Reset value	MSB 0	0	0	0	0	0	0	LSB 0
0057h	SCIPETPR Reset value	MSB 0	0	0	0	0	0	0	LSB 0

12.2.2 Current characteristics

Table 84. Current characteristics

Symbol	Ratings	Max value	Unit
I_{VDD}	Total current into V_{DD} power lines (source) ⁽¹⁾	32-pin devices	75
		44-pin devices	150
I_{VSS}	Total current out of V_{SS} ground lines (sink) ⁽¹⁾	32-pin devices	75
		44-pin devices	150
I_{IO}	Output current sunk by any standard I/O and control pin	20	mA
	Output current sunk by any high sink I/O pin	40	
	Output current source by any I/Os and control pin	- 25	
$I_{INJ(PIN)}^{(2)(3)}$	Injected current on V_{PP} pin	± 5	
	Injected current on \overline{RESET} pin	± 5	
	Injected current on OSC1 and OSC2 pins	± 5	
	Injected current on ROM and 32 Kbyte Flash devices PB0 pin	± 5	
	Injected current on 8/16 Kbyte Flash devices PB0 pin	+ 5	
	Injected current on any other pin ⁽⁴⁾⁽⁵⁾	± 5	
$\Sigma I_{INJ(PIN)}^{(2)}$	Total injected current (sum of all I/O and control pins) ⁽⁴⁾	± 25	

1. All power (V_{DD}) and ground (V_{SS}) lines must always be connected to the external supply.
2. $I_{INJ(PIN)}$ must never be exceeded. This is implicitly insured if V_{IN} maximum is respected. If V_{IN} maximum cannot be respected, the injection current must be limited externally to the $I_{INJ(PIN)}$ value. A positive injection is induced by $V_{IN} > V_{DD}$ while a negative injection is induced by $V_{IN} < V_{SS}$. For true open-drain pads, there is no positive injection current, and the corresponding V_{IN} maximum must always be respected.
3. Negative injection degrades the analog performance of the device. See note in [Section 12.13.3: ADC accuracy on page 174](#). If the current injection limits given in [Section Table 105.: General characteristics on page 162](#) are exceeded, general device malfunction may result.
4. When several inputs are submitted to a current injection, the maximum $\Sigma I_{INJ(PIN)}$ is the absolute sum of the positive and negative injected currents (instantaneous values). These results are based on characterization with $\Sigma I_{INJ(PIN)}$ maximum current injection on four I/O port pins of the device.
5. True open drain I/O port pins do not accept positive injection.

12.2.3 Thermal characteristics

Table 85. Thermal characteristics

Symbol	Ratings	Value	Unit
T_{STG}	Storage temperature range	-65 to +150	°C
T_J	Maximum junction temperature (see Section 13.3: Thermal characteristics)		

12.7.2 Flash memory

Table 100. Dual voltage HDFlash memory

Symbol	Parameter	Conditions	Min ⁽¹⁾	Typ	Max ⁽¹⁾	Unit
f _{CPU}	Operating frequency	Read mode	0		8	MHz
		Write/Erase mode	1		8	
V _{PP}	Programming voltage ⁽²⁾	4.5V ≤ V _{DD} ≤ 5.5V	11.4		12.6	V
I _{DD}	Supply current ⁽³⁾	Write/Erase		<10		μA
I _{PP}	V _{PP} current ⁽³⁾	Read (V _{PP} = 12V)			200	μA
		Write/Erase			30	mA
t _{VPP}	Internal V _{PP} stabilization time			10		μs
t _{RET}	Data retention	T _A = 55°C	20			years
N _{RW}	Write/Erase cycles	T _A = 85°C	100			cycles
T _{PROG} T _{ERASE}	Programming or erasing temperature range		-40	25	85	°C

1. Data based on characterization results, not tested in production.
2. V_{PP} must be applied only during the programming or erasing operation and not permanently for reliability reasons.
3. Data based on simulation results, not tested in production.

Table 114. 32-pin low profile quad flat package mechanical data (continued)

Dim.	mm			inches		
	Min	Typ	Max	Min	Typ	Max
L1		1.00			0.039	
Number of pins						
N	32					

13.3 Thermal characteristics

Table 115. Thermal characteristics

Symbol	Ratings	Value	Unit
R_{thJA}	Package thermal resistance (junction to ambient): LQFP44 10x10 LQFP32 7x7	52 70	°C/W
P_D	Power dissipation ⁽¹⁾	500	mW
T_{Jmax}	Maximum junction temperature ⁽²⁾	150	°C

1. The maximum power dissipation is obtained from the formula $P_D = (T_J - T_A) / R_{thJA}$. The power dissipation of an application can be defined by the user with the formula: $P_D = P_{INT} + P_{PORT}$ where P_{INT} is the chip internal power ($I_{DD} \times V_{DD}$) and P_{PORT} is the port power dissipation depending on the ports used in the application.
2. The maximum chip-junction temperature is based on technology characteristics.

13.4 Ecopack information

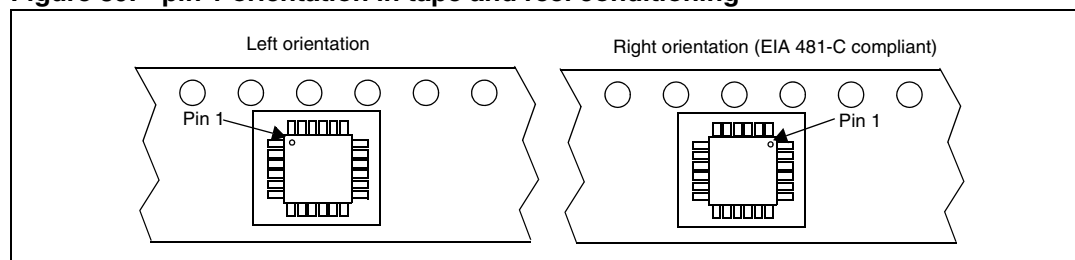
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

13.5 Packaging for automatic handling

The devices can be supplied in trays or with tape and reel conditioning.

Tape and reel conditioning can be ordered with pin 1 left-oriented or right-oriented when facing the tape sprocket holes as shown in [Figure 89](#).

Figure 89. pin 1 orientation in tape and reel conditioning



See also [Figure 90: ST72F324Bxx-Auto Flash commercial product structure on page 182](#) and [Figure 91: ST72P324Bxx-Auto FastROM commercial product structure on page 184](#).

16 Revision history

Table 123. Document revision history

Date	Revision	Changes
23-May-2007	1	Initial release
23-Jul-2007	2	<p>Replaced ST72324B-Auto with ST72324Bxx-Auto in document title on cover page.</p> <p>1 analog peripheral (low current coupling) on page 1: Replaced '12 robust input ports' with '12 input ports'</p> <p>Table 1: Device summary on page 1: Corrected order of listed packages</p> <p>Added Section 1.2: Differences between ST72324B-Auto and ST72324B datasheets on page 16</p> <p>Figure 2: 44-pin LQFP package pinout on page 17: Displayed port numbers for pins 18 and 20 (port numbers were hidden due to formatting error)</p> <p>Table 2: Device pin description on page 18:</p> <ul style="list-style-type: none"> - replaced V_{DDA} with V_{REF} in Note 1 - modified Note 2 <p>Section 5.3.4: Condition Code register (CC) on page 29: Replaced IxSPR with ISPRx</p> <p>Section 9.5.1: I/O port implementation on page 65: Removed following tables:</p> <ul style="list-style-type: none"> - Standard ports PA5:4, PC7:0, PD5:0, PE1:0, PF7:6, 4 - Interrupt ports PB4, PB2:0, PF2:0 (with pull-up) - Interrupt ports PA3, PB3 (without pull-up) - True open drain ports PA7:6 (configurations in these four tables already exist in Table 32: Port configuration) <p>Section 12.6.3: Crystal and ceramic resonator oscillators: Replaced two tables Crystal and ceramic resonator oscillators (8/16K Flash and ROM devices) and Crystal and ceramic resonator oscillators (32 Kbyte Flash and ROM devices) with single Table 95: Crystal and ceramic resonator oscillators on page 156</p> <p>Table 96: OSC RANGE selection for typical resonators on page 157: Deleted footnote detailing SMD and LEAD which was linked to 'Reference' column header</p> <p>Table 102: EMI emissions on page 161:</p> <ul style="list-style-type: none"> - added LQFP32 package to all listed devices - changed values for 32 Kbyte ROM devices <p>Table 105: General characteristics on page 163:</p> <ul style="list-style-type: none"> - modified Note 5 - modified Note 6 <p>Figure 76: RESET pin protection when LVD is enabled(1)(2)(3)(4)(5)(6) on page 168: Replaced 'MW' with 'M ohm' in footnotes to correct formatting error</p> <p>Table 111: 10-bit ADC characteristics on page 172: Modified input current leakage parameter and added Note 2</p> <p>Table 112: ADC accuracy on page 175:</p> <ul style="list-style-type: none"> - added conditions to total unadjusted error, to offset error and to gain error - modified Note 2